Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/771,176	CHENG ET AL.	
Examiner	Art Unit	
Queenie Dehghan	1731	

Queenie Dehghan

SEARCHED				
Class	Subclass	Date	Examiner	
65	17.2,427, 395,397, 399	1/31/2006	QSD	
		,		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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DATE	EXMR
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2/2/2006	QSD
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